

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HEEMSKERK ET AL.	
		Examiner Mark L. Berch	Art Unit 1624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0124029	06-2005	Alkema et al.	435/050
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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